

Ultrafast imaging technology

From visible light to high-energy X-ray photons

Zhehui (Jeff) Wang

P-25, LANL

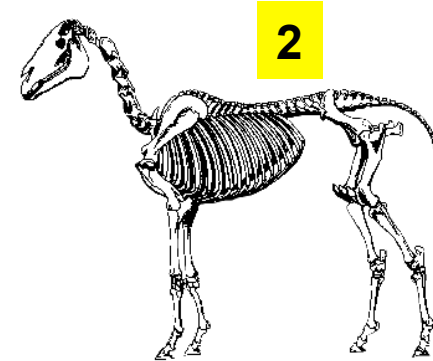
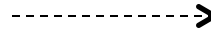
P/T colloquium, Jan. 19, 2017



Dynamic, fast & interesting

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How fast is ultrafast?



Outline

■ Introduction

- Historical highlights of high-speed photography/imaging
- Recent advances in ultrafast imaging technology

■ New ingredients for ultrafast imaging

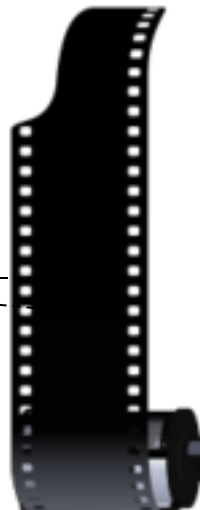
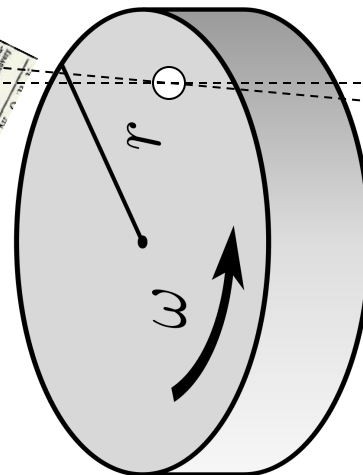
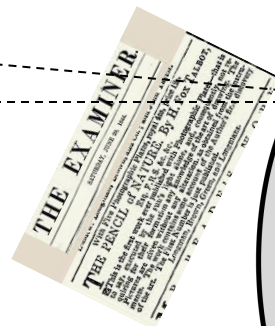
- photons + cameras + data
- LANL interest → MaRIE & others (LCLS, APS, etc)

■ Towards gigahertz HE x-ray imaging

- *Software: Data challenge (acquisition, storage, transport, processing)*
- *Hardware: Materials challenge*
 - Conventional “bulk” materials → **architecture innovations (near term)**
 - Micro/Nano materials → Proof-of-concepts (Long term)

William Henry Fox Talbot

and the Invention of high-speed photography



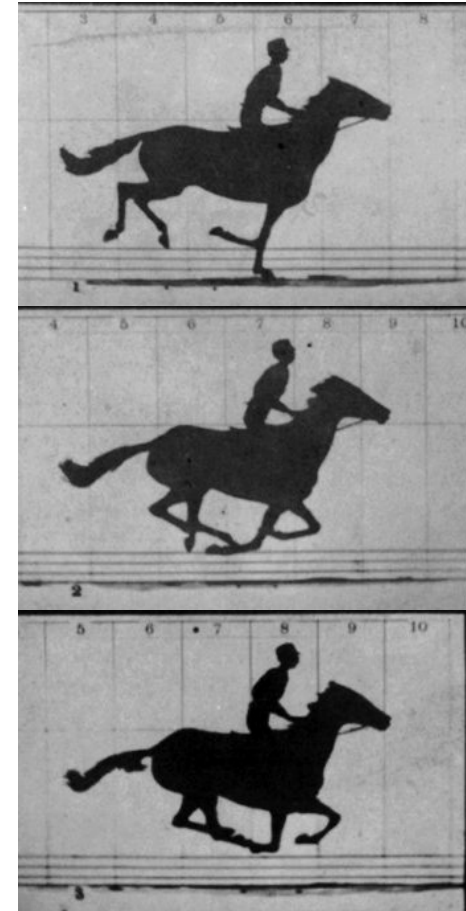
Further progress in this direction would not be difficult
--British J. Photography, 1864

Eadweard Muybridge

and the galloping horse photography



Muybridge designed his own high speed electronic shutter and electro-timer



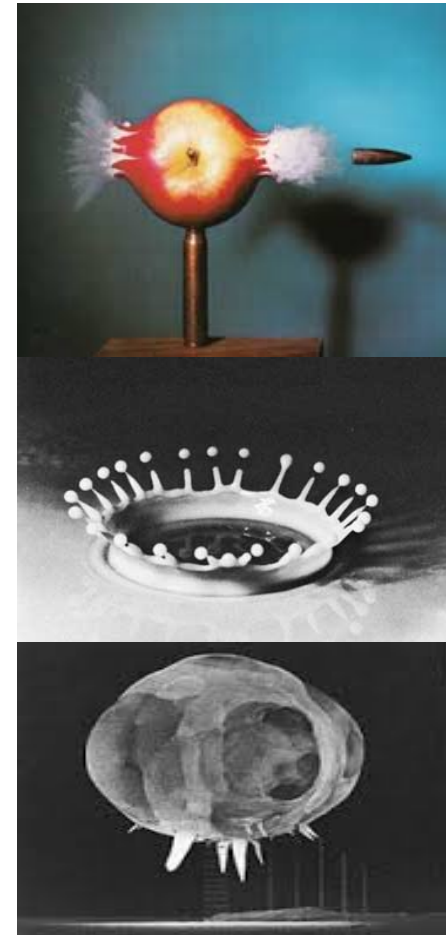
Harold "Doc" Edgerton

and stroboscope photography



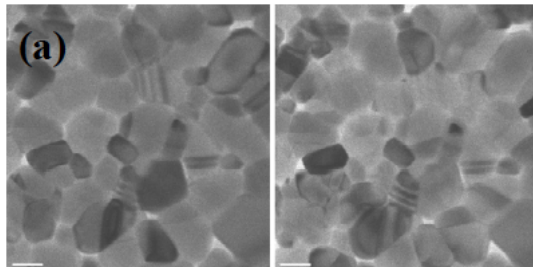
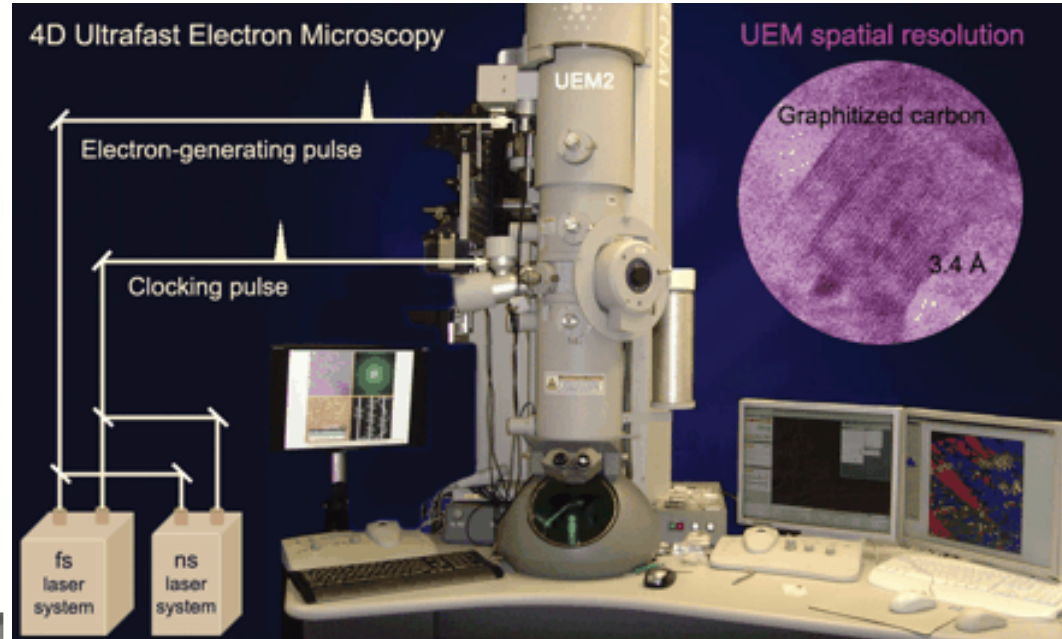
"perfected strobe lighting"

EG&G founder

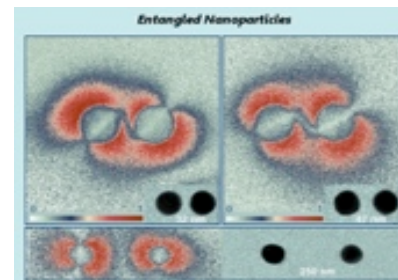


Ahmed Zewail

and the dancing molecule photography



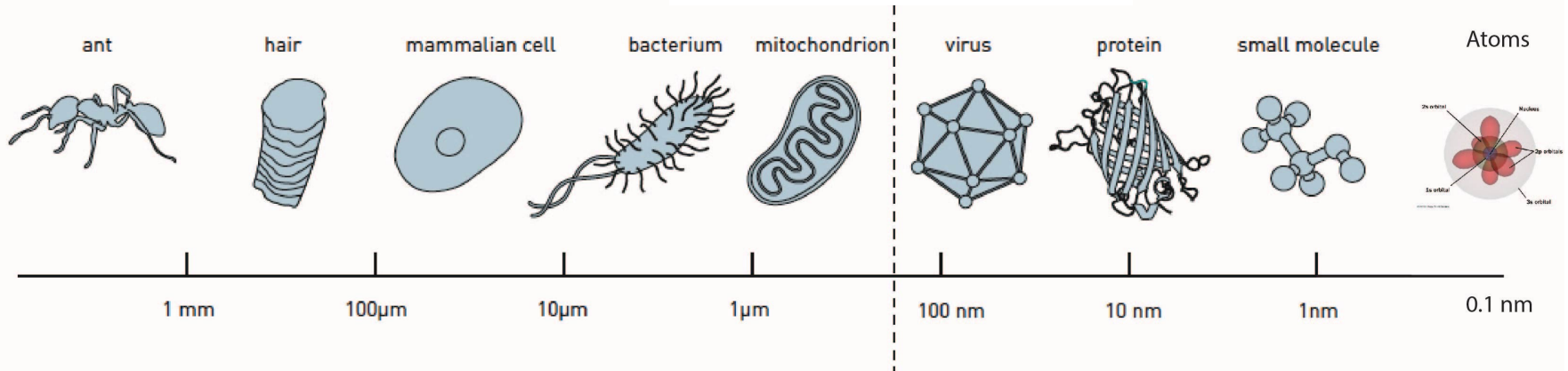
VO₂ phase transition



Entangled nanoparticles

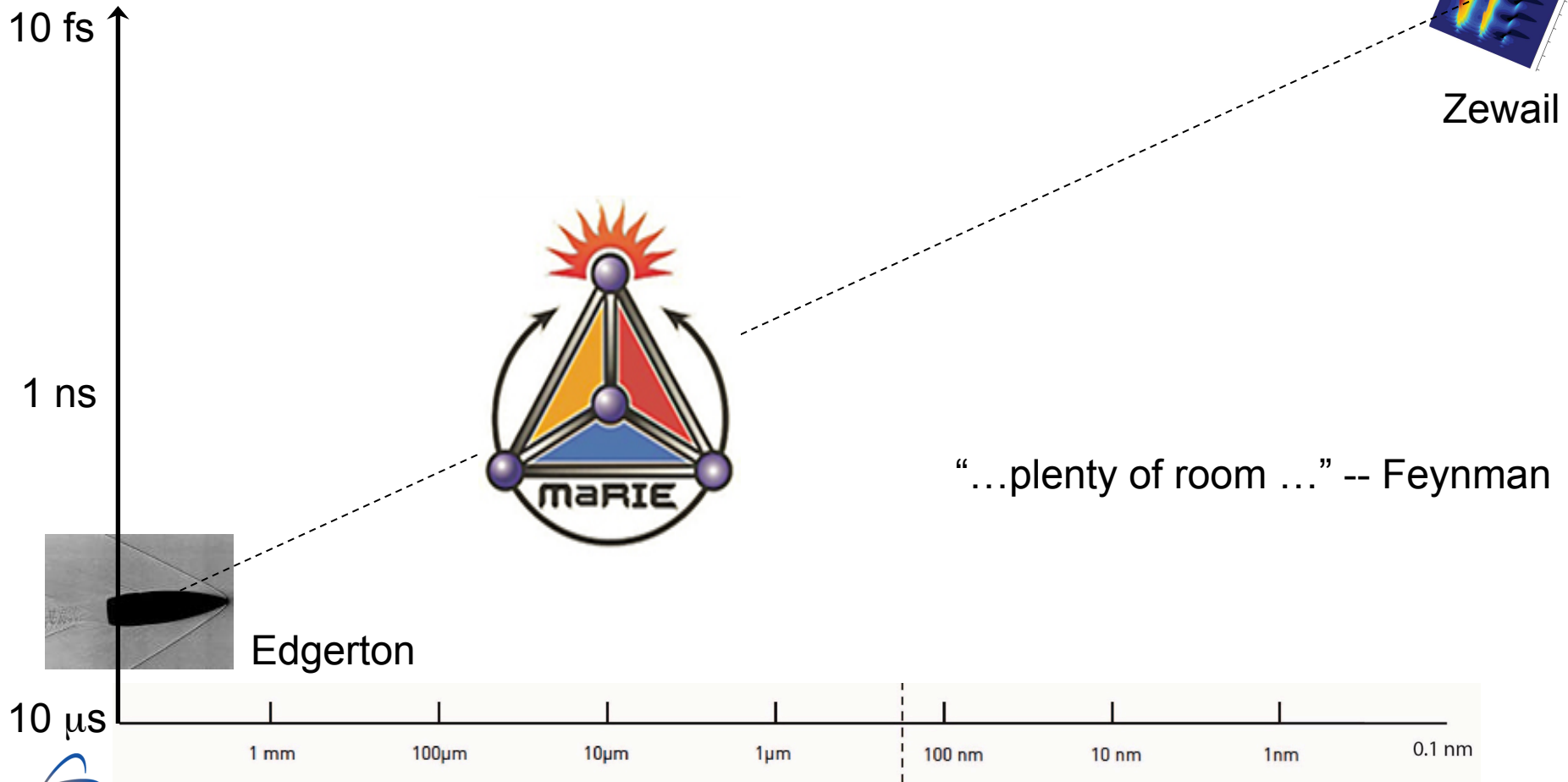
Plenty of 'horses' grazing in nature: from mm- to nano- land

Biology:



Material science, Geology, Quantum world, ...

Camera frame-rate inversely proportional to dimensions

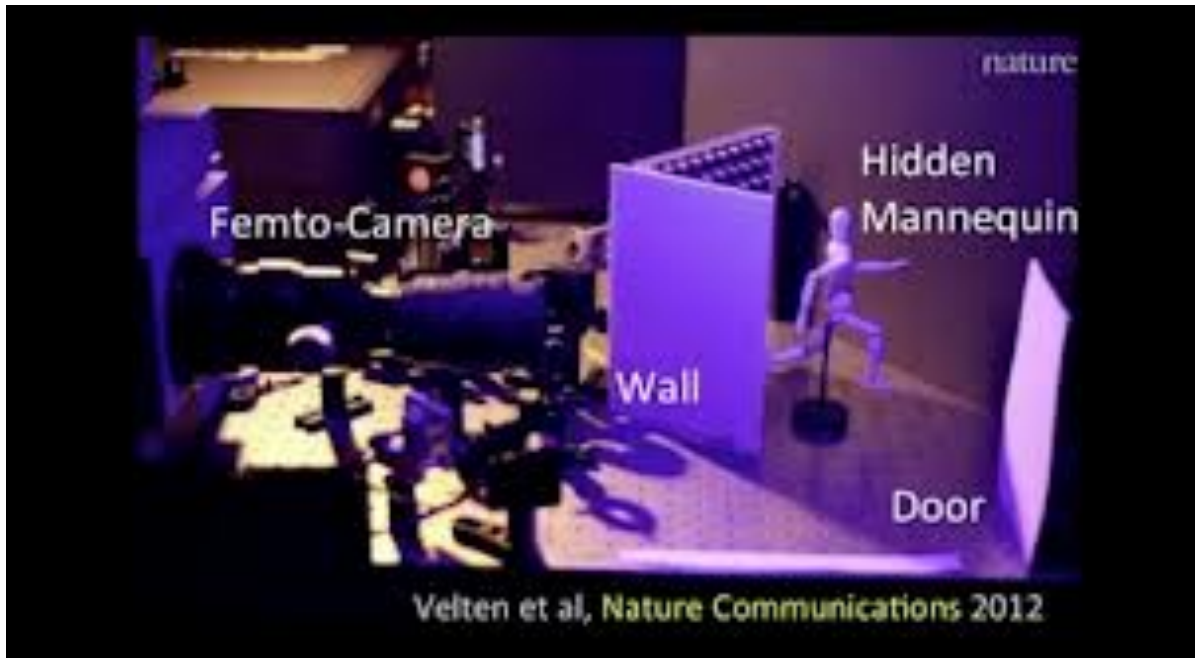


Is ultrafast imaging boring for macroscopic objects?



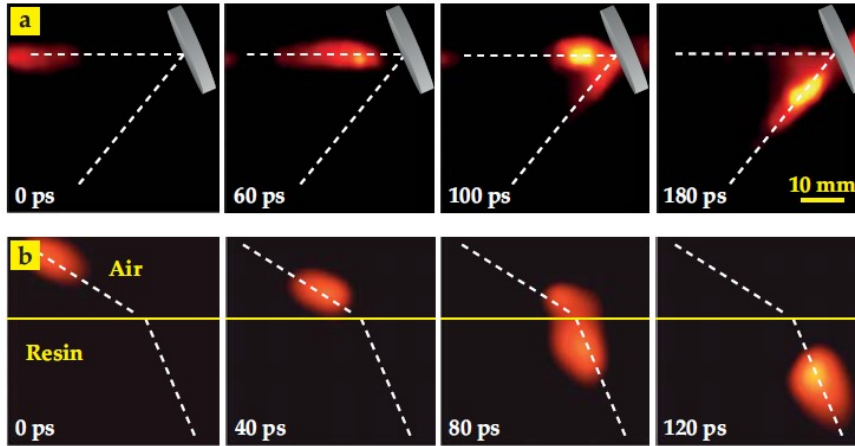
Non-trivial macroscopic applications

Seeing things around the corner

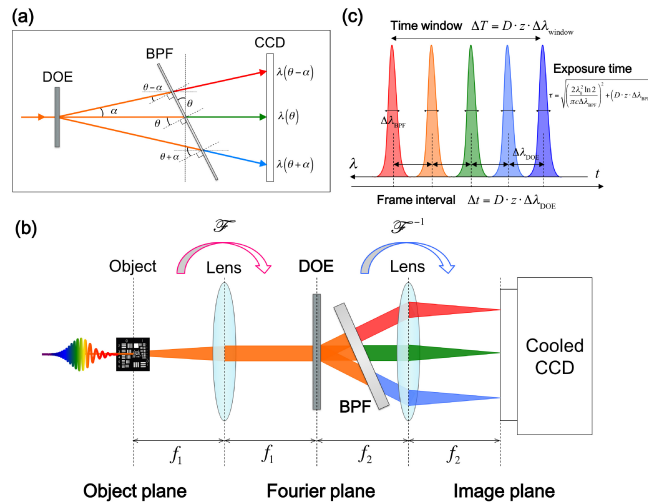


R. Raskar et al. — MIT Media Lab

“Trillion frame cameras” for visible light booming



“CUP”
Gao et al (2014)



“STAMP”
Suzuki et al (2015)

Outline

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- Recent advances in ultrafast imaging technology

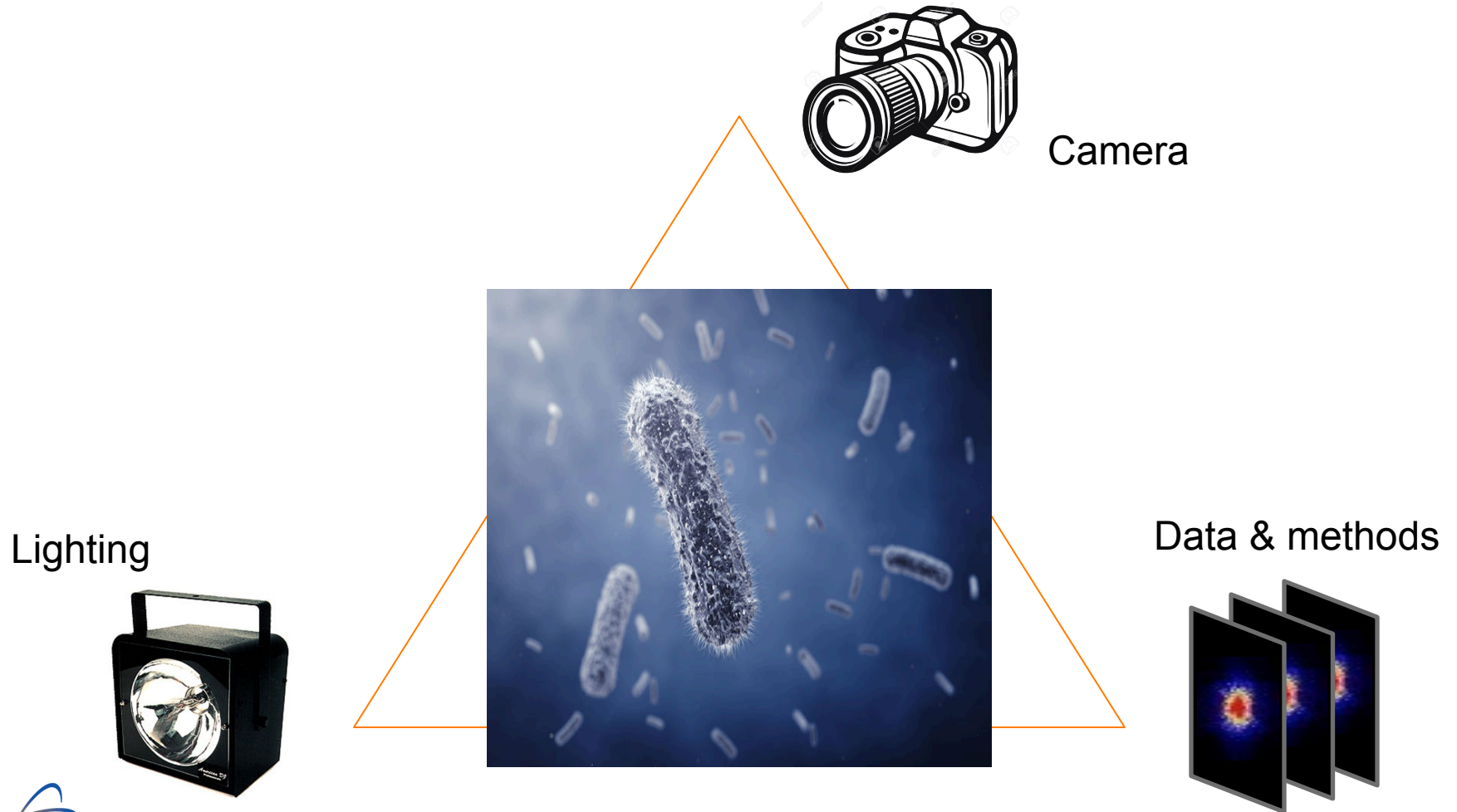
■ New ingredients for ultrafast imaging

- Lighting + cameras + data
- LANL interest → MaRIE & others (LCLS, APS, etc)

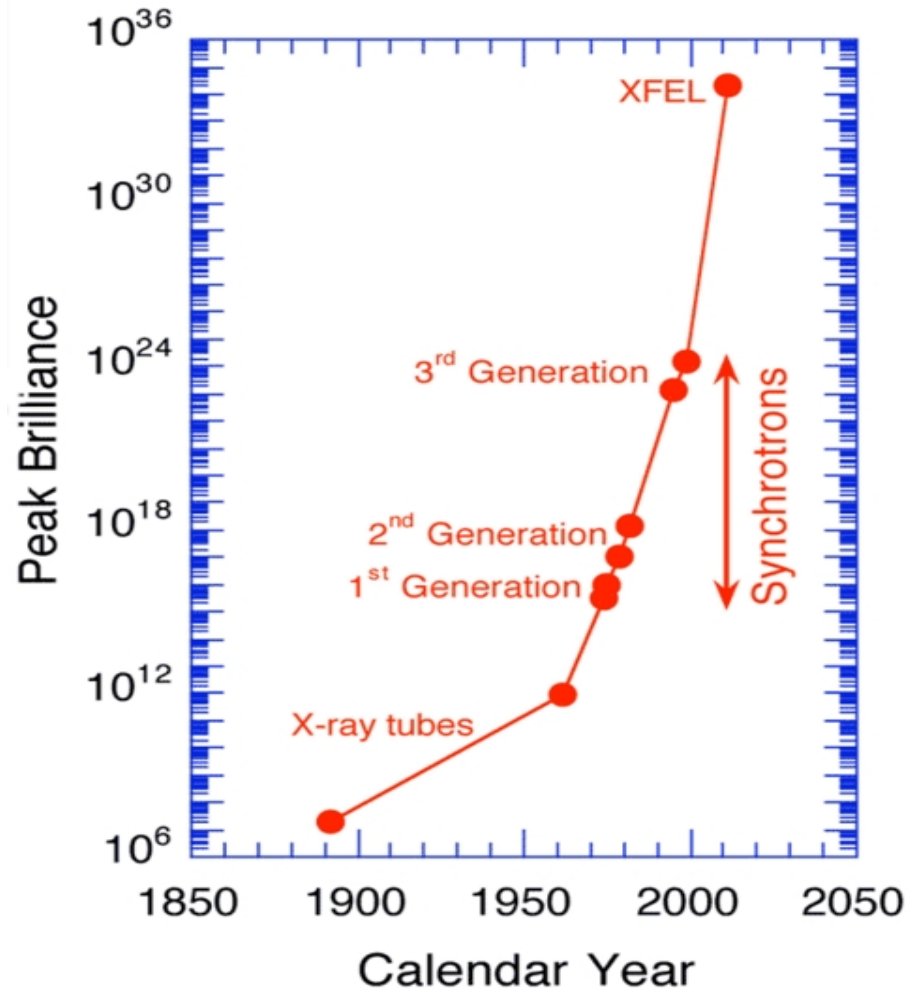
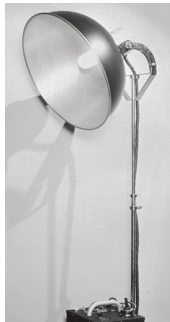
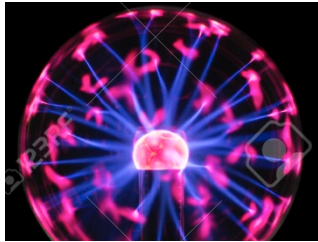
■ Towards gigahertz HE x-ray imaging

- *Software: Data challenge (acquisition, storage, transport, processing)*
- *Hardware: Materials challenge*
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 - Micro/Nano → Proof-of-concepts (Long term)

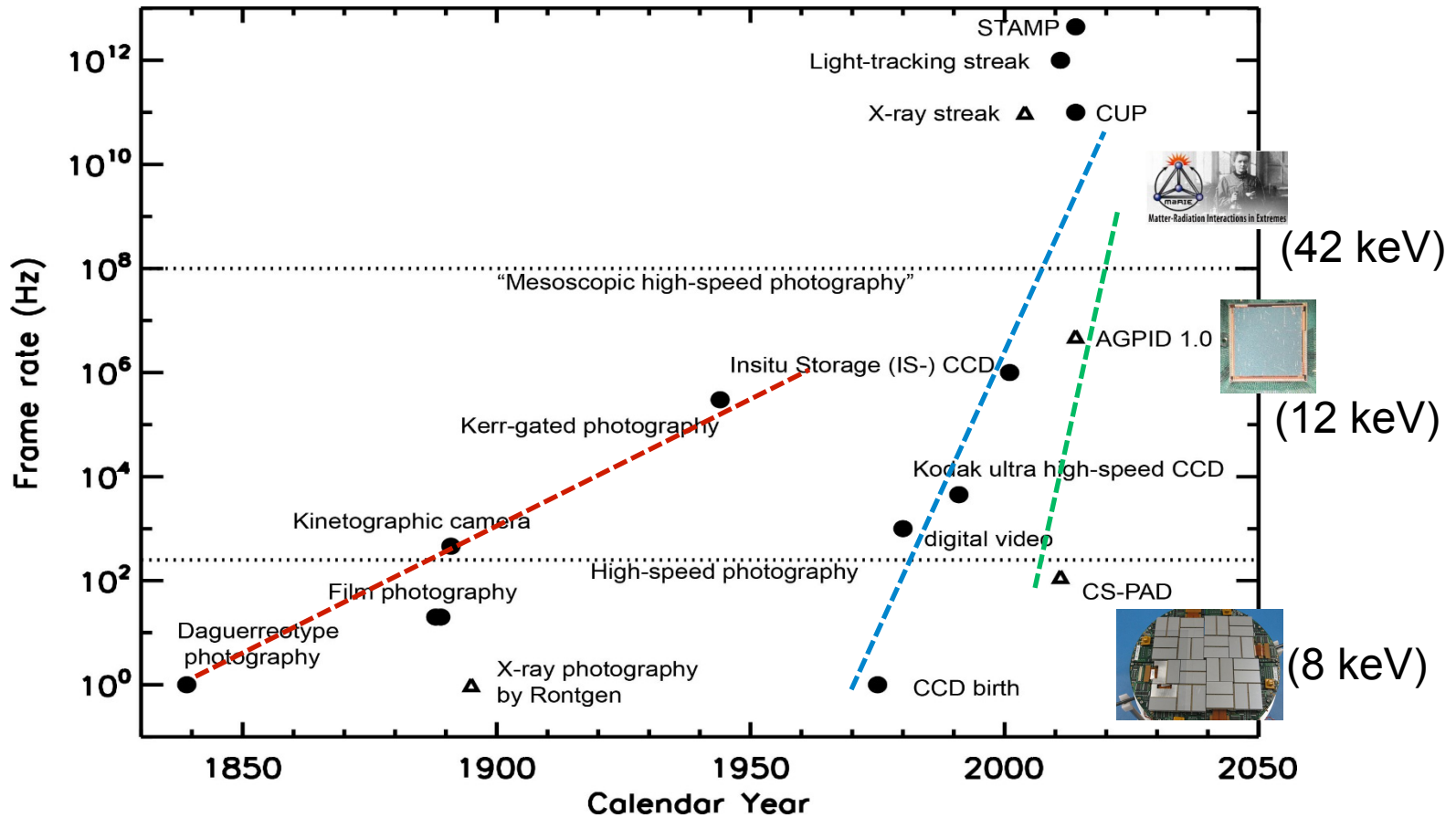
High-speed imaging technology triangle



Evolution of lighting



Evolution of high-speed imaging technologies



A lot of parallel efforts...

XFEL

sync

XFEL

XFEL

XFEL

XFEL

XFEL

XFEL

XFEL

HEP

sync

Detector/ Camera	Voxel dimension (μm^3)	Noise	CMOS technol. (μm)	Pixel Bias (V)	Digital clock (MHz)	Frame rate (MHz)
CSPAD	110 × 110 × 500	330 e ⁻	0.25 (TSMC)	190	25	1.2 × 10 ⁻⁴
ePix100a	50 × 50 × 500	50 e ⁻	0.25 (TSMC)	200	0.1	1.2 × 10 ⁻⁴
Keck-PAD	150 × 150 × 500	1530e ⁻ (860 μV)	0.25 (TSMC)	200	50	6.5
AGIPD 1.0	200 × 200 × 500	265e ⁻ <14.4	0.13 (IBM)	500	99	4.5
DSSC (DEPFET)	136 (hex) × 450	50 e ⁻	0.13 (IBM)	150	700	5
pnCCD (CAMP)	75 × 75 × 280	5 e ⁻ (100 ms)	CCD	140 (0.5V/ μm)	10	2.5 × 10 ⁻⁴ (5, burst)
LPD	500 × 500 × 500	1000 e ⁻	0.13 (IBM)	~250	100	4.5
MPCCD [HG:2015]	50 × 50 × 50	200 e ⁻	CCD	~20	5	6 × 10 ⁻⁵
SOPHIAS	30 × 30 × 500	150 e ⁻	0.2 FD-SOI	~200	25	6 × 10 ⁻⁵
JUNGFRAU [SMS:2015]	75 × 75 × 450	100 e ⁻	0.11 (UMC)	220	40	2.4 × 10 ⁻³
ALPIDE ² (MAPS ³)	28 × 28 × 50	~ 20 e ⁻	0.18 (TowerJazz)	<10	40	5.0 × 10 ⁻²
FASPAX [ZIM:2016]	100 × 100 × 500	<1000 e ⁻	130nm SiGe (IBM)	1000	100	13 (burst)

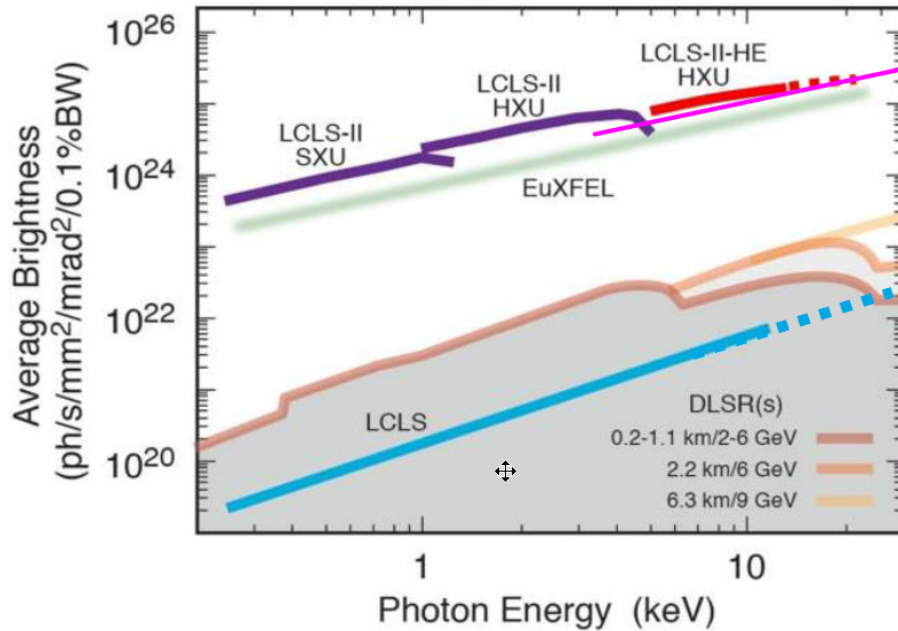
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MaRIE driven ultrafast imaging technology

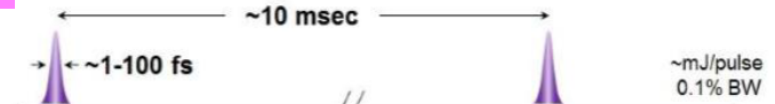
Inputs: Rich Sheffield, Dinh Nguyen



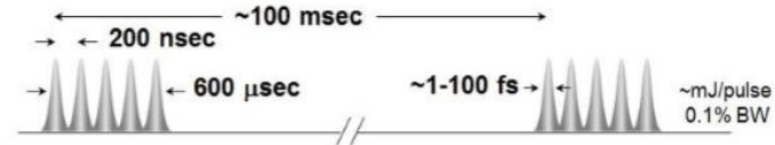
MaRIE
(w/o seeding)

MaRIE

LCLS



EuXFEL



LCLS-II (HE)



DLSRs



T. Raubenheimer
LCLS-II-HE Workshop, September 26-27, 2016
P. Abbamonte et al., SLAC-R-1053 (2015)

MaRIE-camera: Performance summary

- **PicoSecond sensor <-> Materials challenge**
 - highly efficient (>50%) x-ray detection at 30-keV and above energies.
 - Sub-ns (<100-ps) X-ray sensor and storage response.
- **GigaHertz frame-rate <-> Fabrication/scaling challenge**
 - Many pixels, interframe time, 300 ps (3 GHz)
 - Multiple frames per experiment/ framing for acoustic velocities across grains
 - Single line-of-sight
- **Large data <-> Data challenge**
 - 3 MB per image (20 bit, 1 Mpix)
 - Up to 10^6 images per experiment
 - big data sets transmission and processing driven by scientific “co-design”



The August 2016 workshop

High-energy and Ultrafast X-Ray Imaging Technologies and Applications

A MaRIE workshop shining a light on the future of ultrafast high-energy photon technology

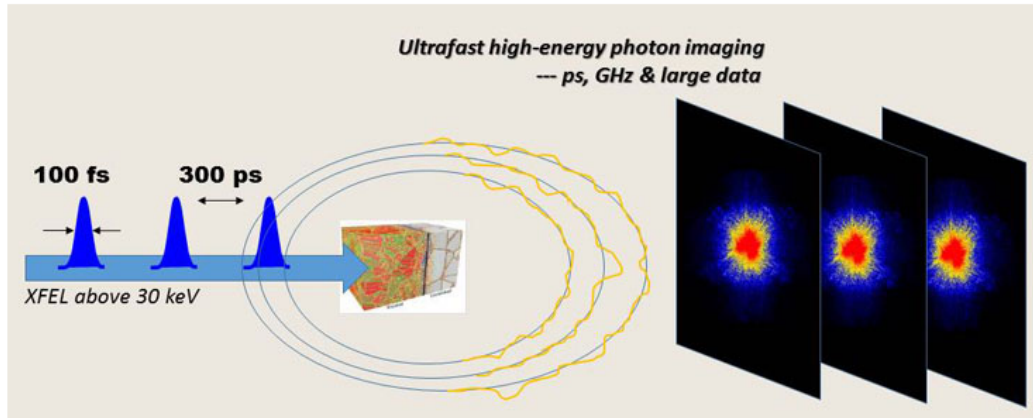
ACCOMMODATIONS

ABSTRACTS

REGISTRATION

PROGRAM

TRAVEL



High-energy and Ultrafast X-Ray Imaging Technologies and Applications

Date : August 2–3, 2016

Hotel venue: Hilton Santa Fe at Buffalo Thunder

The goal of this workshop is to gather leading experts in the fields related to ultrafast high-energy photon imaging and prioritize the path forward for ultrafast hard x-ray imaging technology development, identify important applications in the next 5–10 years, and establish foundations for near-term R&D collaboration.

This workshop is one in a series being organized by Los Alamos National Laboratory to engage broader scientific community in the MaRIE (Matter–Radiation Interactions in Extremes) development process. MaRIE is the proposed



Local Organizers

- Michael Stevens
- Zhehui (Jeff) Wang
(505) 665-5353

Meeting Planner

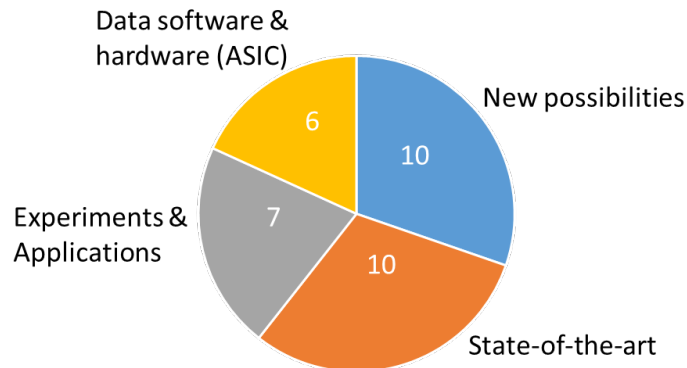
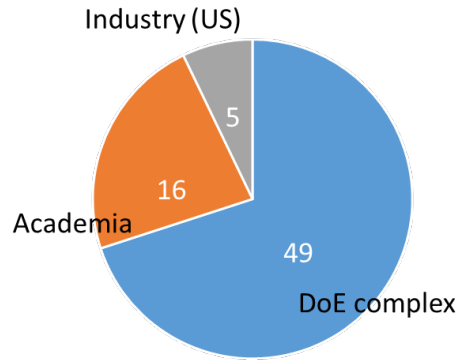
- Peggy Vigil
(505) 667-8448
For logistical purposes
and questions

External

Co-Organizers

- Peter Denes (LBL)
- Sol Gruner (Cornell Univ.)

The August 2016 workshop summary



Ultrafast and High-Energy X-Ray Imaging Technologies & Applications

(August 2-3, 2016; Santa Fe, NM 87506, USA)

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Two-pronged development process: (Low & High Risk)

Performance	Type I imager	Type II imager
X-ray energy	30 keV	42-126 keV
Frame-rate/inter-frame time	0.5 GHz/2 ns	3 GHz / 300 ps
Number of frames	10	10 - 30
X-ray detection efficiency	above 50%	above 80%
Pixel size/pitch	≤ 300 μm	< 300 μm
Dynamic range	10 ³ X-ray photons	≥ 10 ⁴ X-ray photons
Pixel format	64 x 64 (scalable to 1 Mpix)	1 Mpix

MaRIE KPP requirements

ASIC/Data	No. Chan.	Analog bandwidth (GHz)	digital sampling (GHz)	S/N (dB)	Bit Res.	CMOS technol.
PSEC4	6	1.5	15		10.5	IBM 130 nm
"Hawaii chip"	128?	3	20	58 dB/1Vpp	9.4	(TSMC 130 nm)
"Cornell Keck GHz"	384 x 256	0.5				
epixΔ	1M	3			≥ 8	TSMC 250 nm

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- 'Horses' + photons + cameras + data
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■ Towards gigahertz HE x-ray imaging

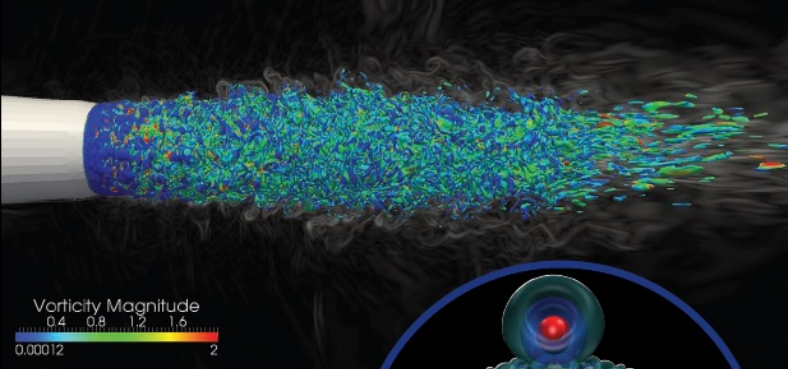
- *Software: Data challenge (acquisition, storage, transport, processing)*
- *Hardware: Materials & engineering challenge*
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 - Micro/Nano → Proof-of-concepts (Long term)

Data challenge: Exascale computing & Data analytics

Solutions in the making

The Opportunities and Challenges of Exascale Computing

Density Gradient
0.2 0.4 0.6 0.8
0.15



Summary Report of the
Advanced Scientific
Computing Advisory
Committee (ASCAC)
Subcommittee

Fall 2010



U.S. DEPARTMENT OF
ENERGY

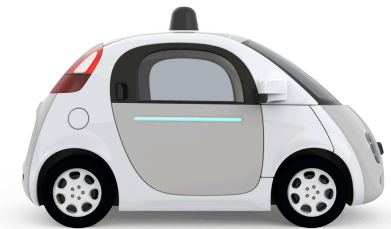
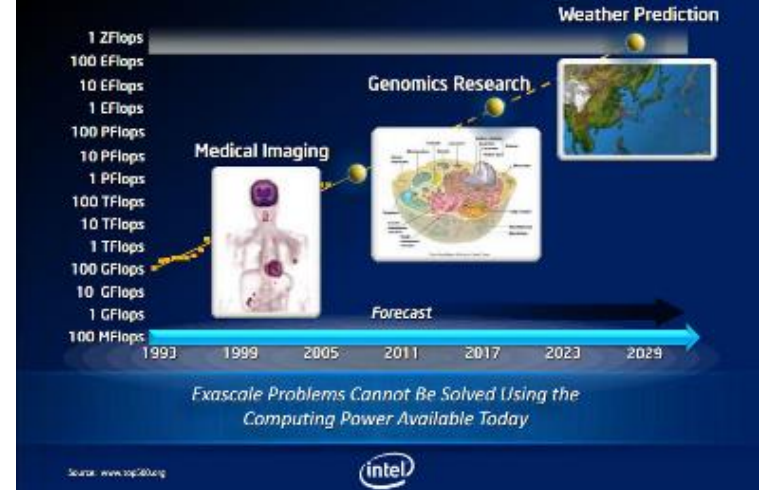
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EST. 1943

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Operated by Los Alamos National Security, LLC for the U.S. Department of Energy's NNSA

An Insatiable Need For Computing

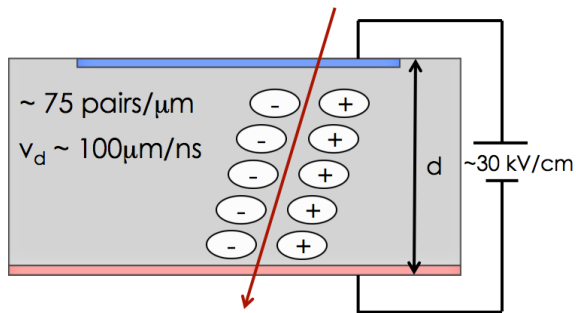


May 2016

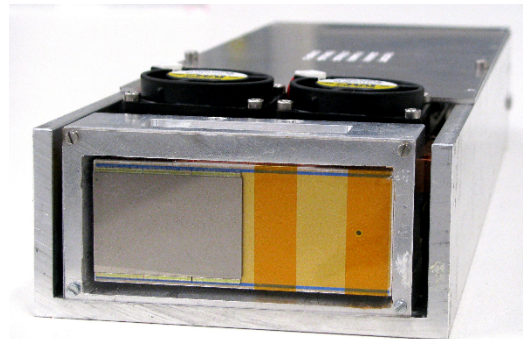
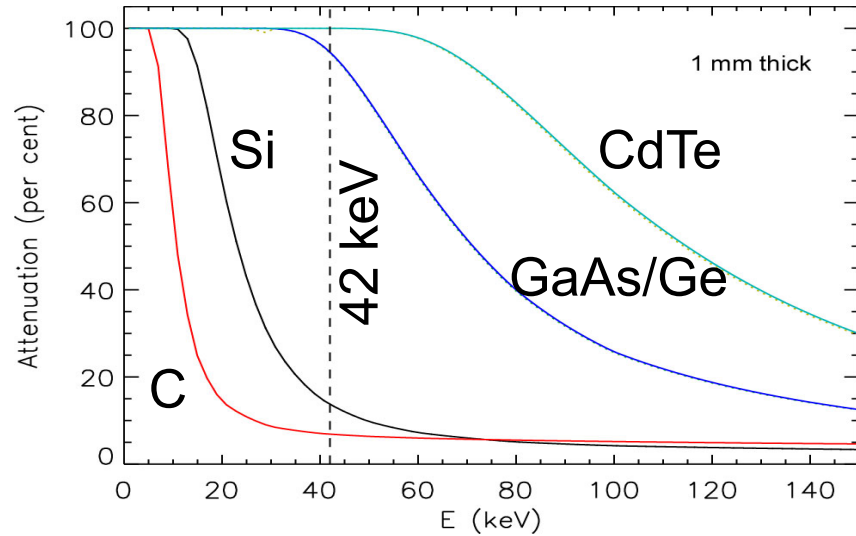
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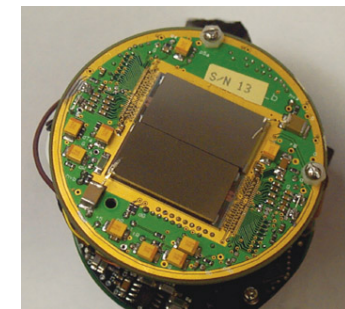
Efficiency (1): High-Z semiconductor sensors



Direct detection



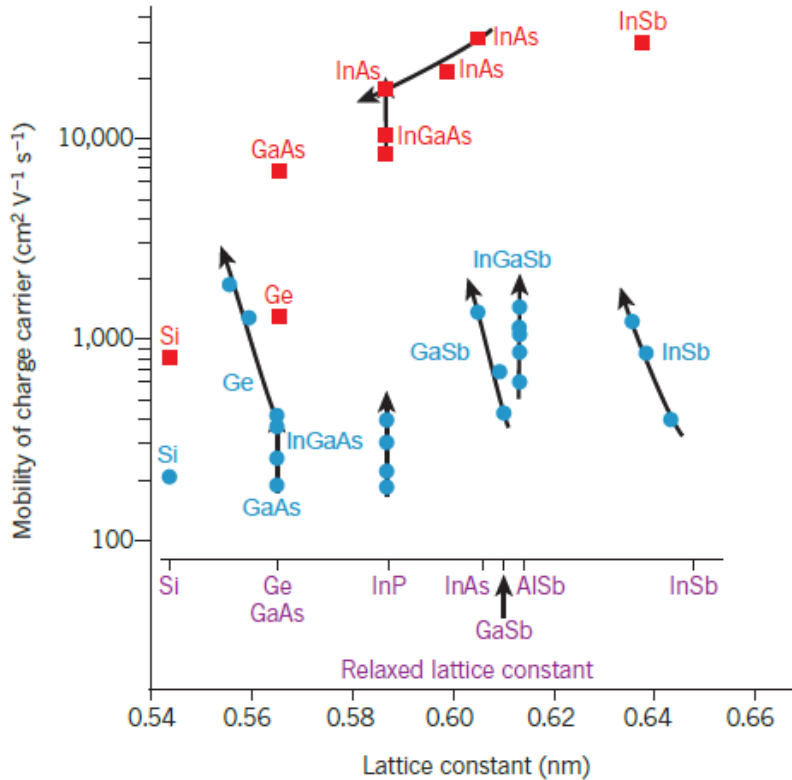
GaAs (DESY)



CZT (LLNL)

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Speed limited by e-/h mobilities, *bandgap also important*



del Alamo, *Nature* 479, 317 (2011)

Material	Mobility, μ , $\text{cm}^2/\text{V}\cdot\text{s}$	Dielectric Constant, ϵ	Bandgap, E_g , eV	Break down field, E_b $10^6\text{V}/\text{cm}$	BFOM Ratio	T_{max} , $^\circ\text{C}$
Si	1300	11.9	1.12	0.3	1.0	300
GaAs	5000	12.5	1.42	0.4	9.6	300
4H-SiC	260	10	3.2	3.5	3.1	600
GaN	1500	9.5	3.4	2	24.6	700

BFOM is Baliga's figure of merit for power transistor performance ($\mu \cdot \epsilon \cdot E_g^3$)

B. J. Baliga, *IEEE Electron Dev. Lett.* **10**, 455 (1989).

	Si	GaAs	6H-SiC	4H-SiC	GaN	Diamond
Bandgap (eV)	1.12	1.43	3.03	3.26	3.45	5.45
Relative dielectric constant	11.9	13.1	9.66	10.1	9	5.5
Breakdown field (kV/cm)	300	400	2500	2200	2000	10000
E mobility (cm^2/Vs)	1500	8500	500	1000	1250	2200
Hole mobility (cm^2/Vs)	600	400	101	115	850	850
Thermal conductivity (W/cmK)	1.5	0.46	4.9	4.9	1.3	22
Saturated electron drift velocity (100 $\mu\text{m}/\text{ns}$)	1	1	2	2	2.2	2.7

L. M. Tolbert, *et al.*, *Proc. IASTED Mult. Conf. Pwr En. Syst.* **7**, 317 (2003).

Thick sensors → insufficient speed for GHz imaging

- Cons: required sensor thickness

	42 keV		126 keV	
	Λ_{tot} (cm)	$3 \Lambda_{tot}$ (cm)	Λ_{tot} (cm)	$3 \Lambda_{tot}$ (cm)
C (Diamond)	1.4	4.2	2.0	6.0
Si	0.7	2.0	2.7	8.1
Ge	3.3e-2	0.1	0.52	1.55
GaAs	3.4e-2	0.1	0.52	1.55
CdTe	9.5e-3	0.028	0.17	0.51

- charge collection length for 1 ns, $\leq 200 \mu\text{m}$
(saturated drift $2 \times 10^7 \text{ cm/s}$)
- aspect ratio, 10 to > 1000 .

→ 100 MHz (Type I technology OK), Type II (GHz difficult)

Dragone et al (2016)

Efficiency (2): Scintillators also have significant problems at GHz

- Pros

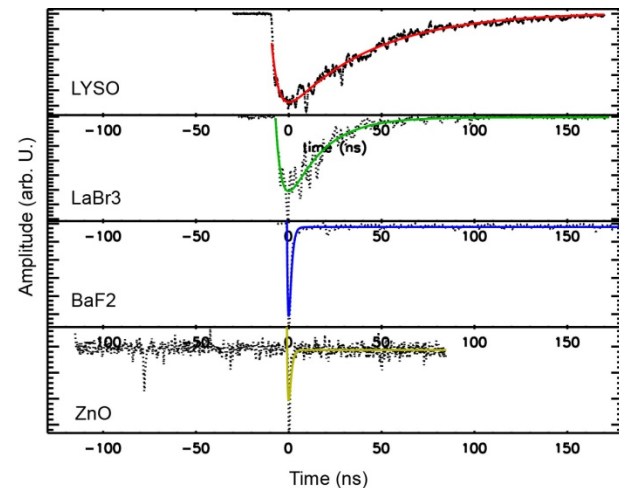
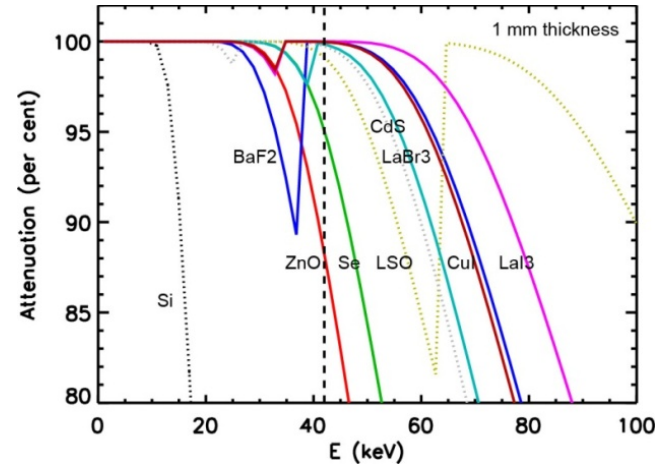
- Light moves x1000 faster than e-.
- Thin scintillators sufficient

- Cons

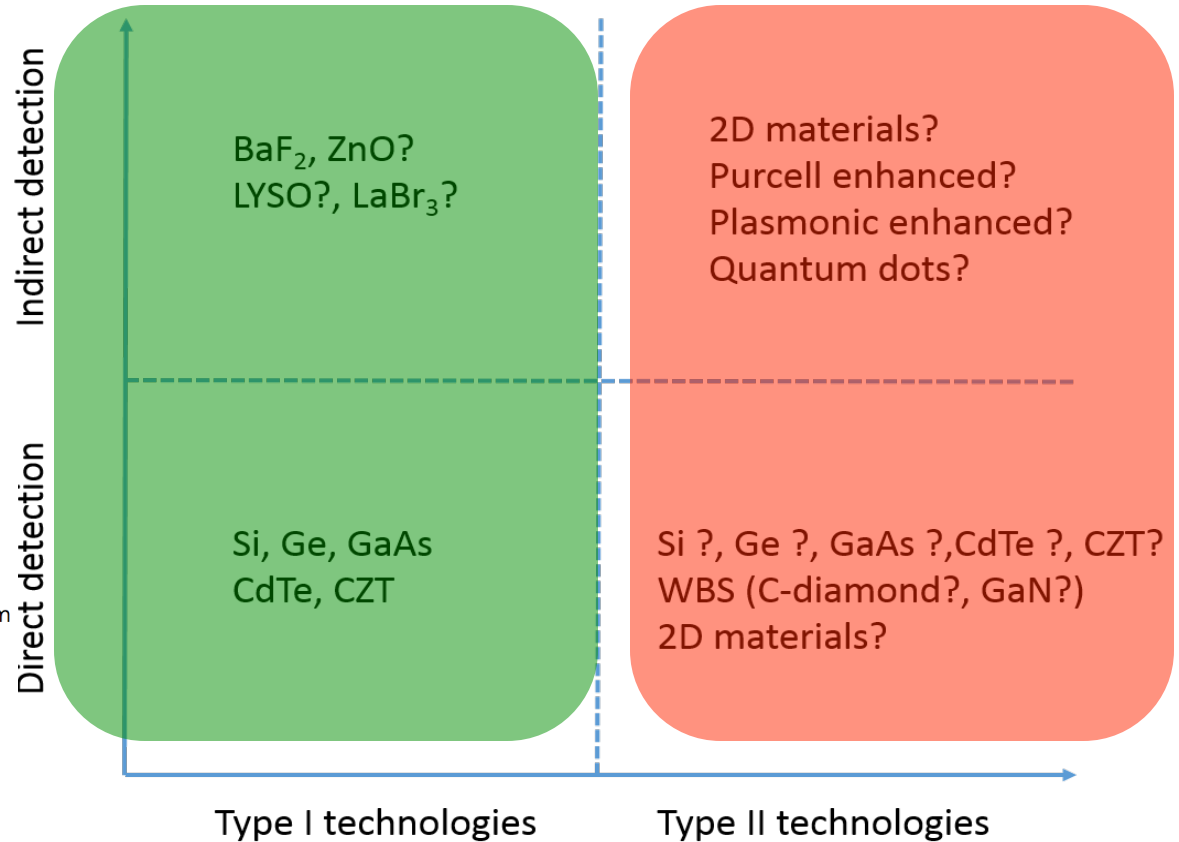
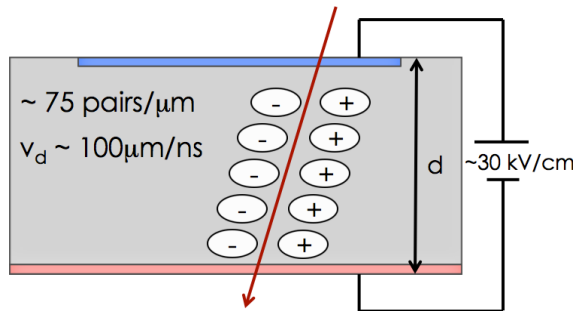
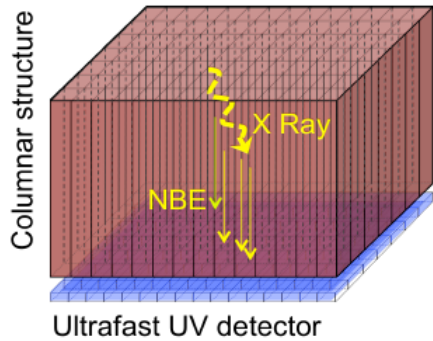
- ✧ Light yield & decay time constants.
- ✧ Needs ultrafast photodetectors (semiconductors)
- ✧ Material supply issues
- ✧ Spatial resolution limited due to internal reflection



(ZnO)

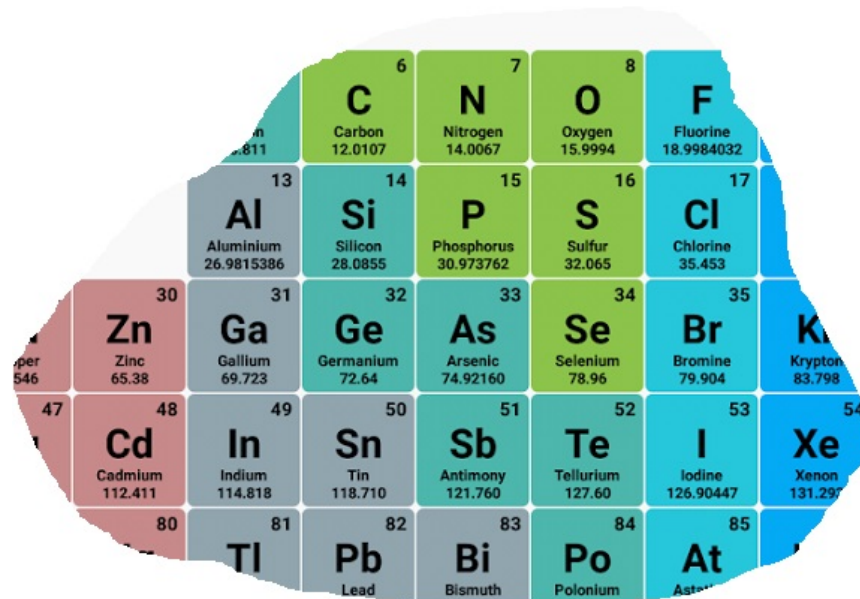


NEED material innovations/discoveries for GHz imaging



Silicon revisited

Is Silicon /CMOS out for GHz HE X-ray imaging?



The fabrication/scaling advantages: CMOS is the best practice

- **Driven by**
 - material selection (Si, SiO₂)
 - Economics / user (consumer) base
- **Leveraging prior development/investment**
 - High-energy physics community (CERN, Fermilab and others)
 - Semiconductor industry

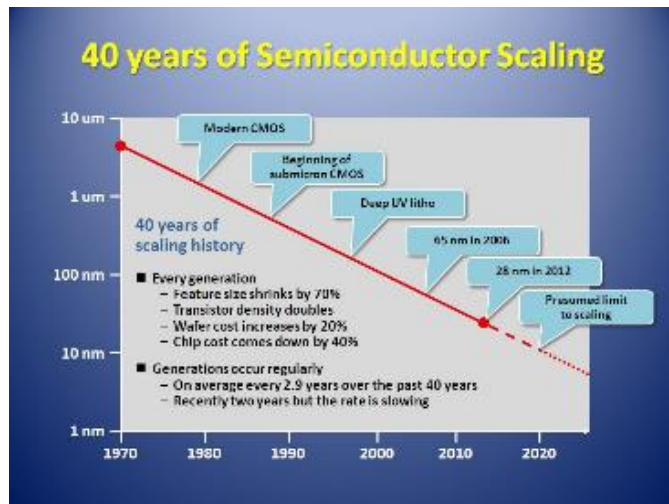
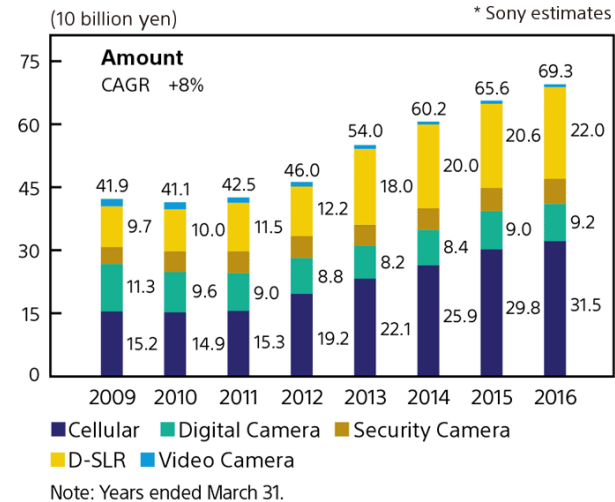
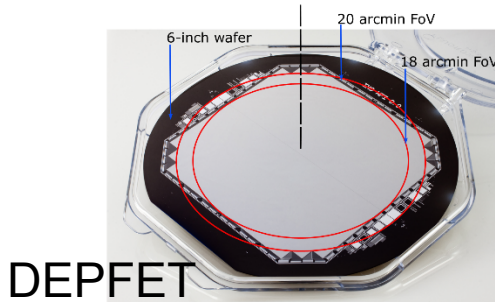


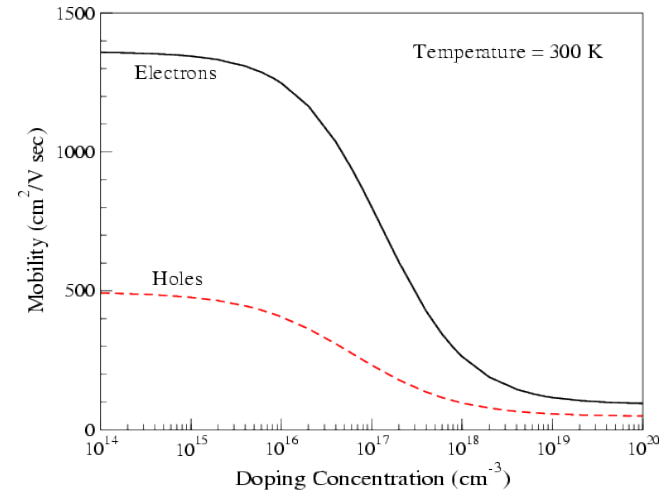
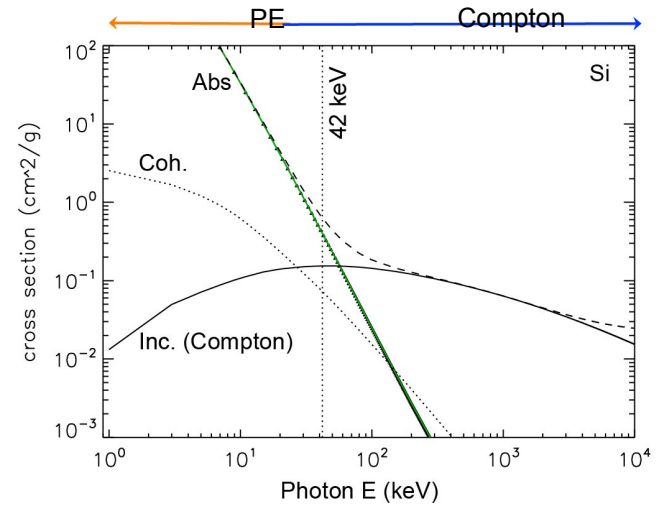
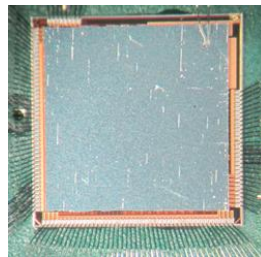
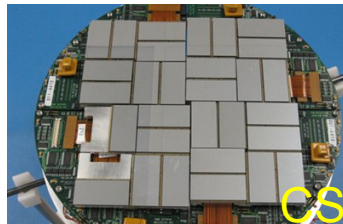
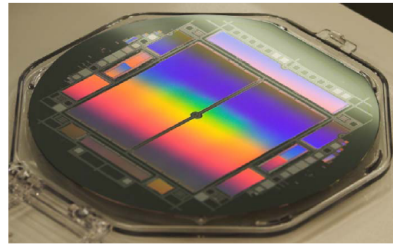
Image Sensor Market by Main Usage



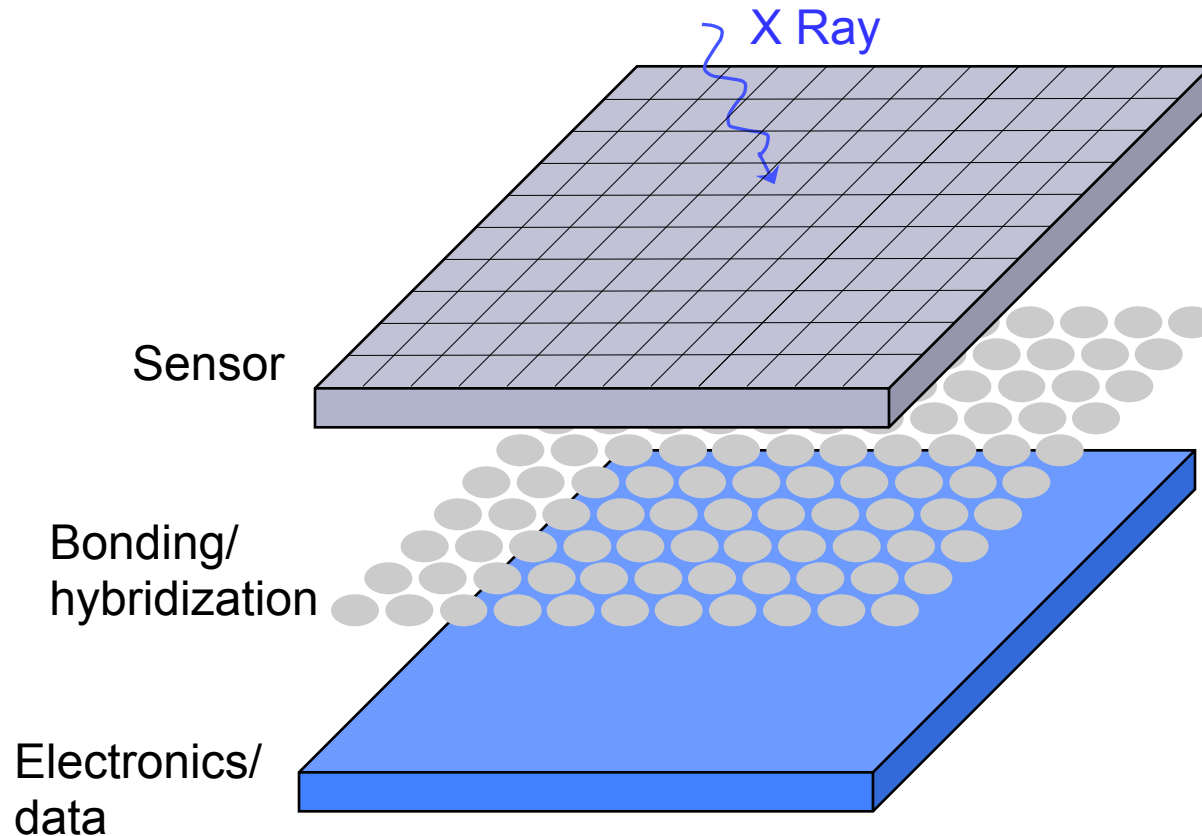
Sound community knowledge base in imaging and other uses



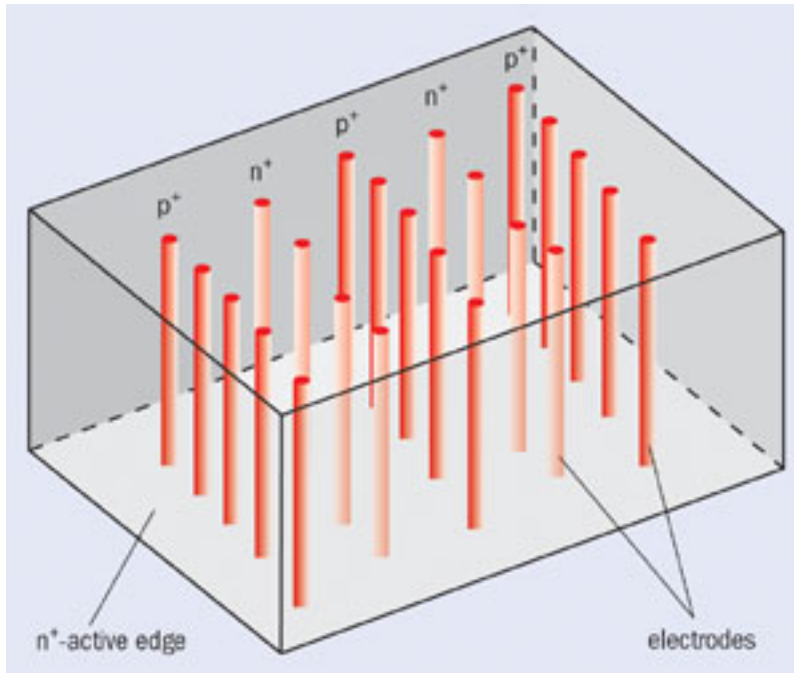
pnCCD



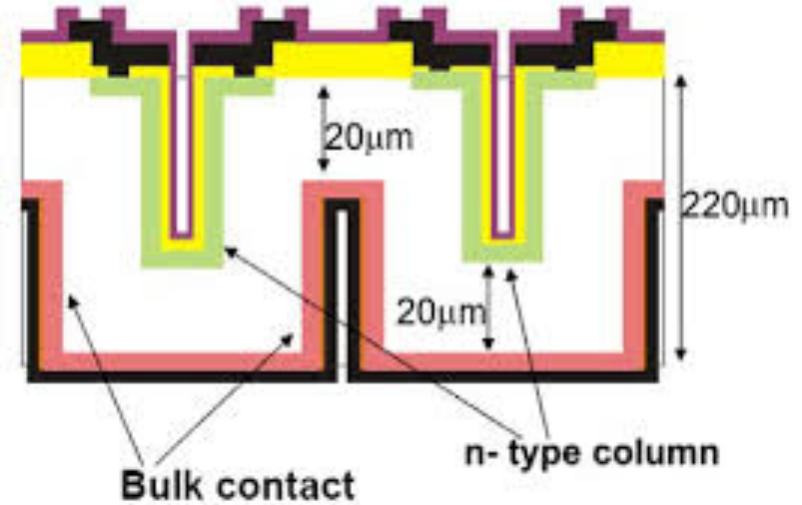
The Problem: 2D hybrid structure can not accommodate speed & efficiency simultaneously



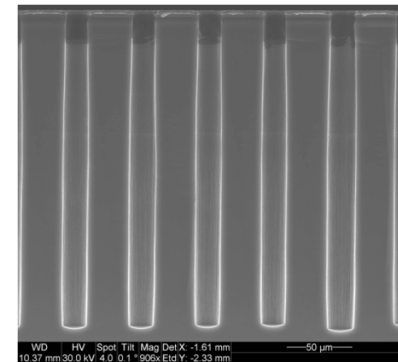
3D Architectural innovations have been proposed before



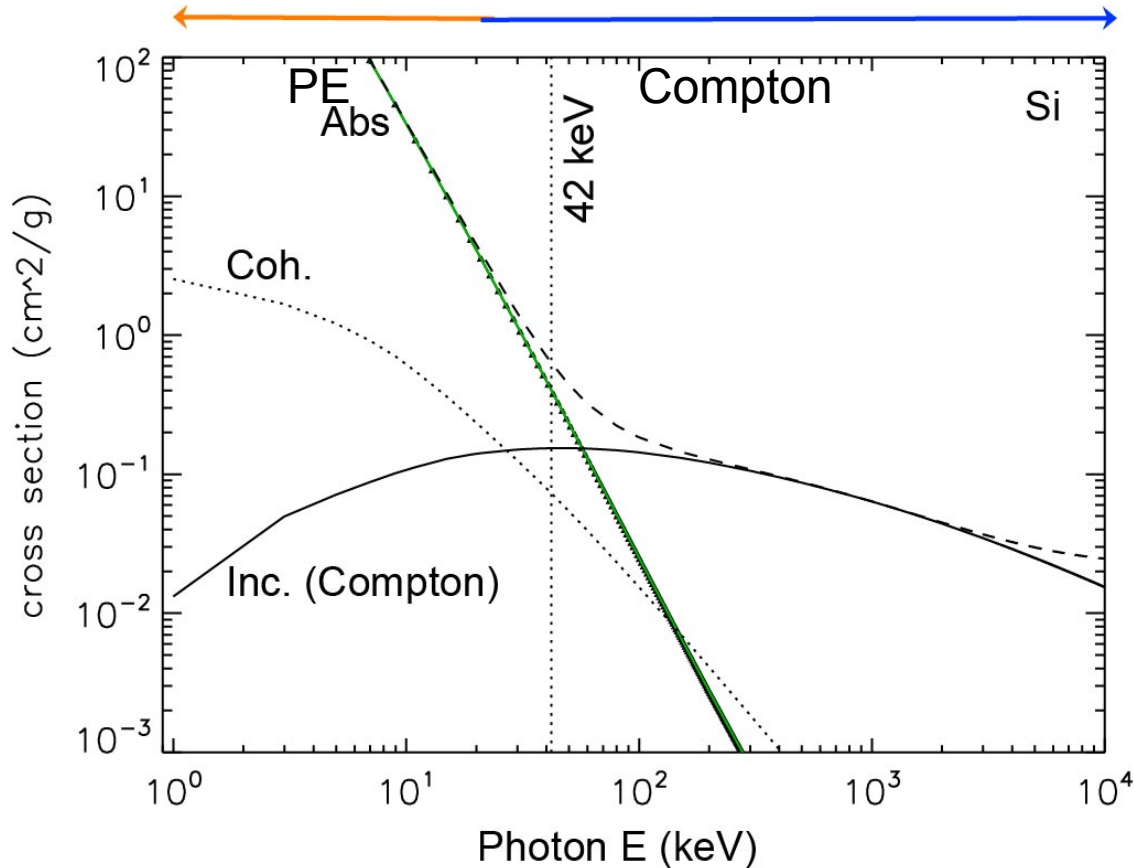
Parker et al (1997)



(2010)



Compton scattering poses a new problem for HE X-rays

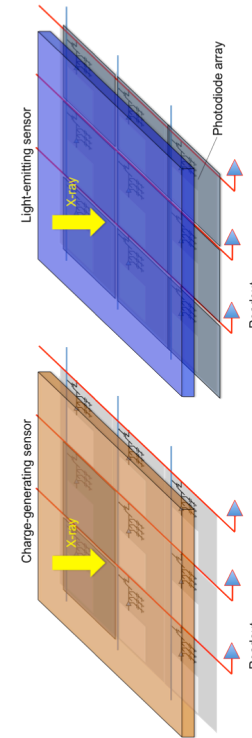
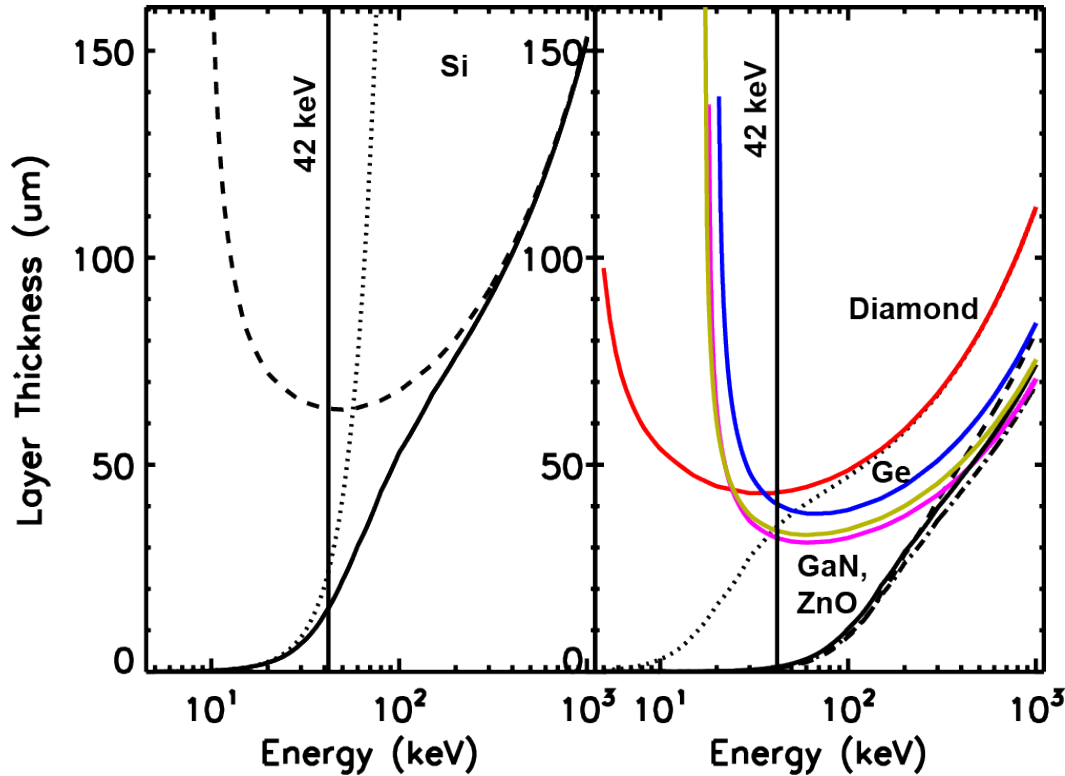


→ Spectroscopy imaging

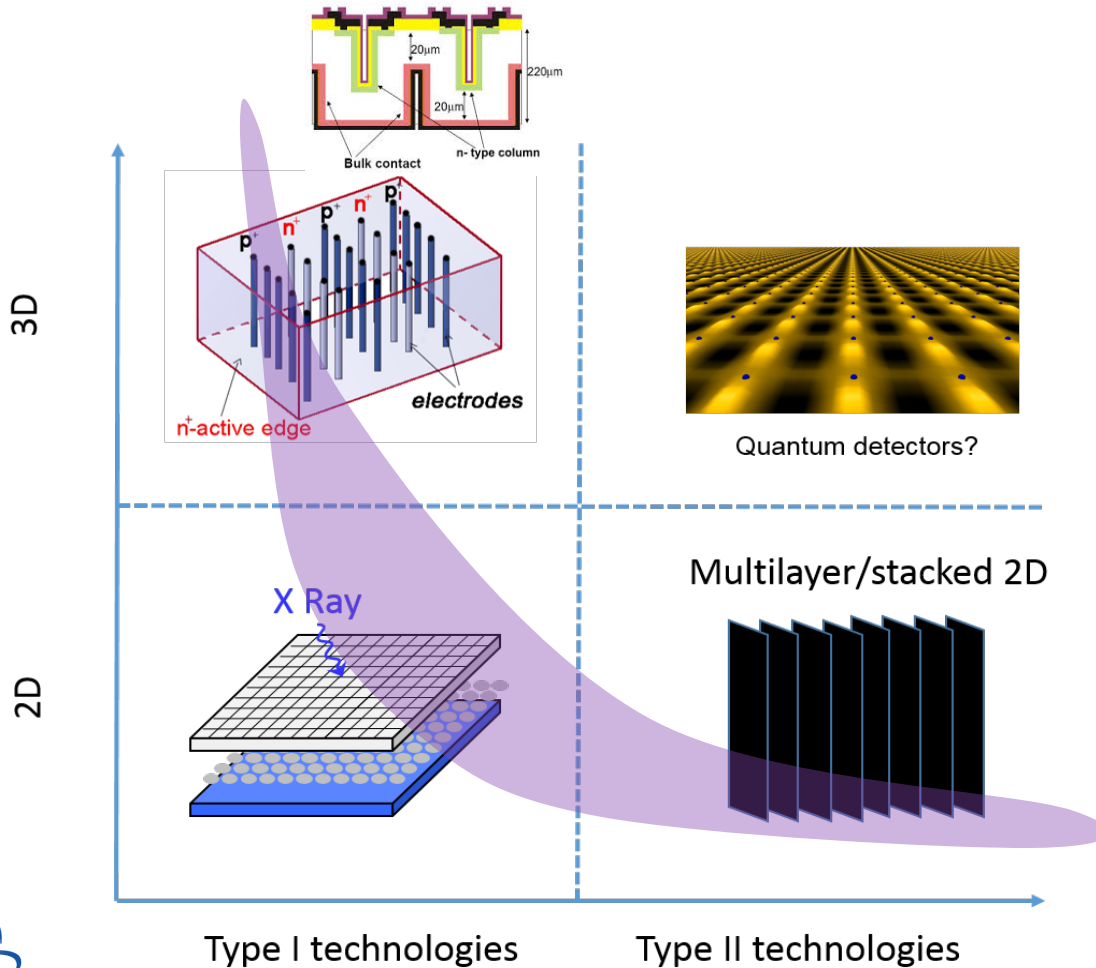
Single-photon counting

Our proposal: Thin-Film Cameras (TFC) using silicon (broader applications than MaRIE)

More details: Wang (2015) JINST 10 C12013



Other structural & processing innovations ?



Material Processes	Features
Thin film process	novel thin-film properties
Additive process	Micro-, nano-grains
Microfluidic process	Versatile nano-particle assembly
Polymer-assisted fabrication	Versatile nano-particle assembly
Self-assembly / biological assisted processes	Autonomous

Existing processes:
CMOS,
SOI,
SiGe.

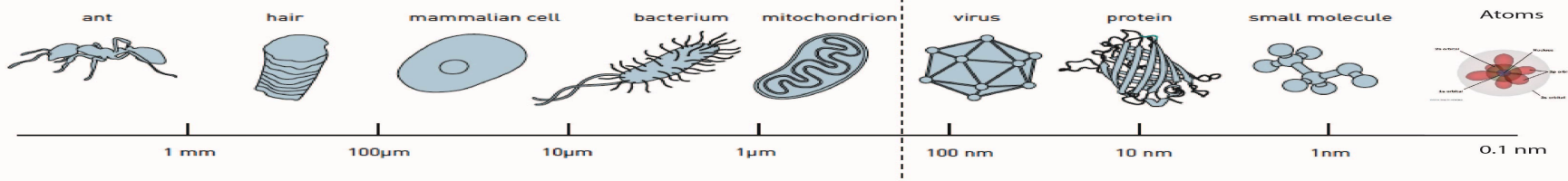
Summary

- Ultrafast imaging technology development requires interdisciplinary approach

→ ‘*global optimization*’ --- Cris W. Barnes

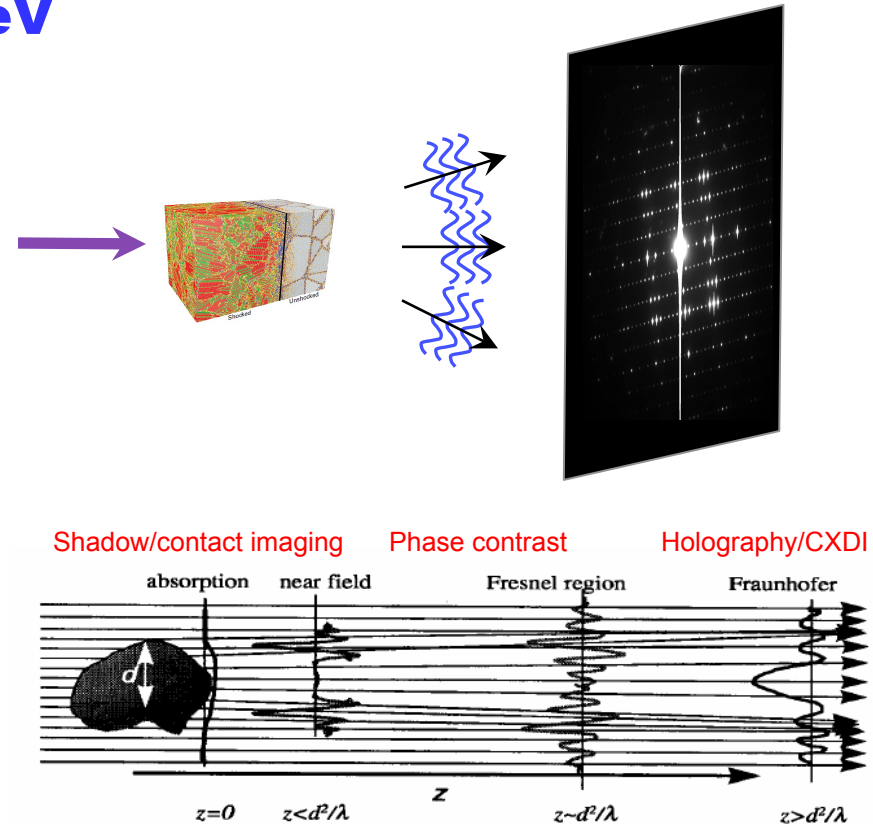
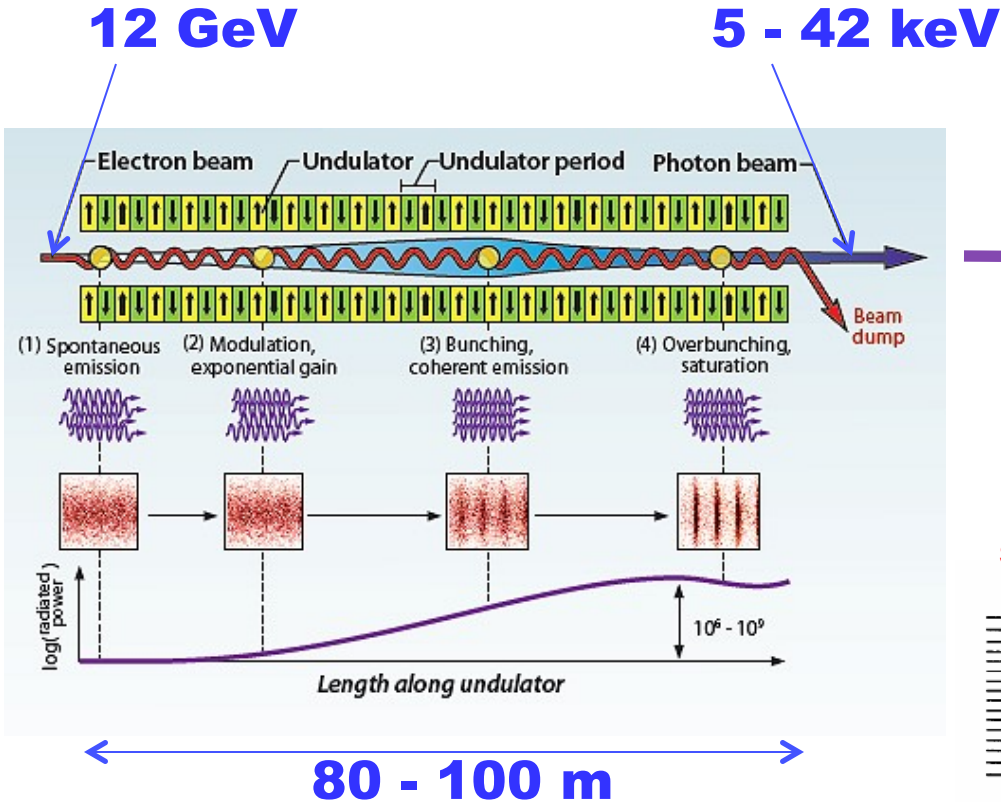
- Material discoveries, device physics, data science, light source experiments
- Parallel development paths (multiple concepts, low+high risk).

→ ~ *Dawn to photograph μ - & nano-horses feeding on atoms and molecules*



Backups

MaRIE XFEL & Experiments



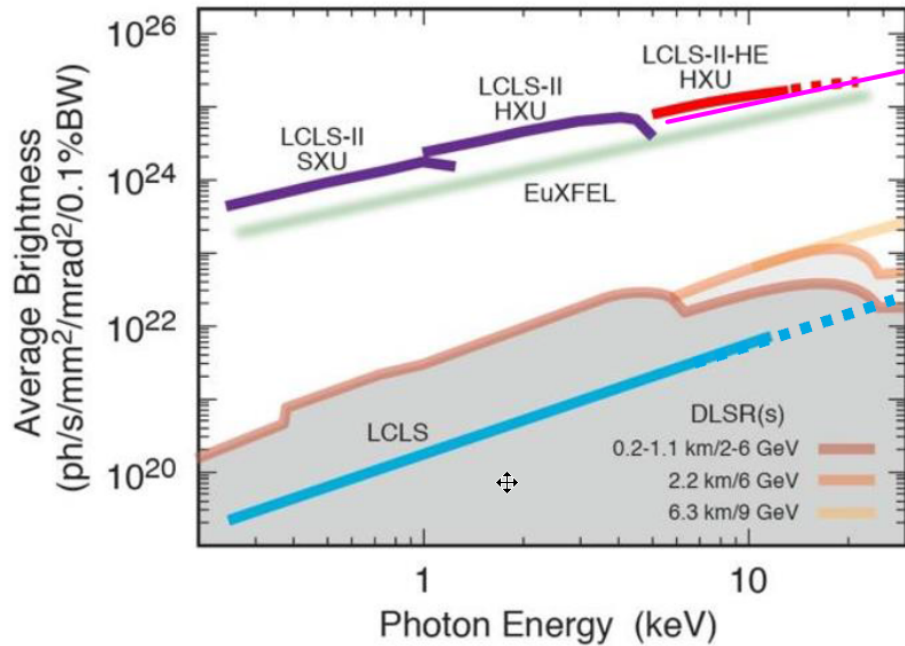
A. Snigirev et al, RSI (1995)

Input: Rich Sheffield, Richard Sandberg

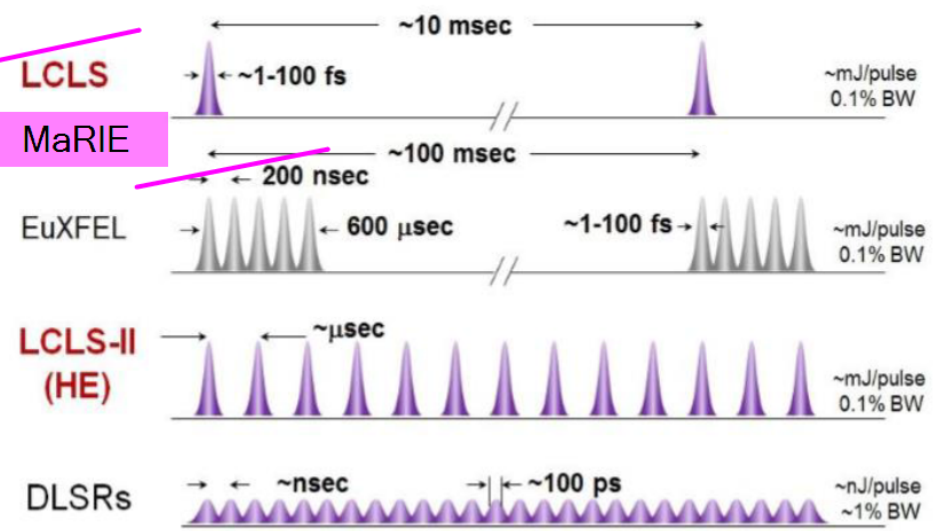
UNCLASSIFIED

3rd harmonic included

Inputs: Rich Sheffield, Dinh Nguyen



MaRIE (w/o seeding)



T. Raubenheimer
LCLS-II-HE Workshop, September 26-27, 2016

P. Abbamonte et al., SLAC-R-1053 (2015)